

Highlights

main title

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- Proposed deep learning-based method to predict iron contamination in Si-SC by using IV curve.
- The simulated IV characteristics are used to create training and test datasets.
- The DNN's configurations are proposed.
- The mean squared relative error of prediction is up to 0.005.

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ABSTRACT

Defect-assisted recombination processes frequently limit the photovoltaic device performance. The low-cost and express methods of impurity contamination control are in demand at solar cell manufacturing. In this paper, we applied deep learning-based approach to extract the iron concentration in silicon solar cell from an ideality factor values.

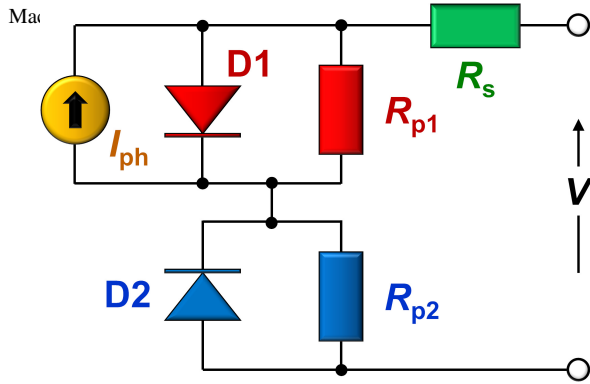


Figure 1: The opposed two-diode equivalent-circuit model of a solar cell.

1. Introduction

2. Models and Methods

2.1. Solar cell model

Fig. 1 vividly reveals the structure of the used model [1]. It can be seen from the figure that model contains a current source accompanied by a diode D1, a shunt resistor R_{p1} to show the leakage current, and a series resistor R_s to consider the losses associated with the load current. Besides, the second diode D2 with a second parallel resistance R_{p2} is placed opposite to the first one and is essential to simulate the non-ideal effects of the active layer/cathode interface. In this model, D1 is responsible for the exponential behavior of the I-V curve, the main contribution of D2 is to simulate the S-shape. The analytical solution $V(I)$ of the opposed two-diode equivalent circuit model was obtained [2] using Lambert W -function [3]:

$$V = (I + I_{ph} + I_{01})R_{p1} - \frac{n_1 kT}{q} W \left\{ \frac{q I_{01} R_{p1}}{n_1 kT} \exp \left[\frac{q R_{p1} (I + I_{ph} + I_{01})}{n_1 kT} \right] \right\} + \frac{n_2 kT}{q} W \left\{ \frac{q I_{02} R_{p2}}{n_2 kT} \exp \left[-\frac{q R_{p2} (I - I_{02})}{n_2 kT} \right] \right\} + (I - I_{02})R_{p2} + I R_s, \quad (1)$$

Table 1

where I_{01} and I_{02} are the saturation currents and n_1 and n_2 are the ideality factors for D1 and D2 respectively, and I_{ph} is the ideal photocurrent. Thus, the model employs eight lumped parameters (I_{01} , n_1 , R_{p1} , I_{02} , n_2 , R_{p2} , R_s , and I_{ph}) that need to be determined from the I-V curve.

The expression (1) has a drawback in that it tends to stray from the range of numbers that can be accommodated by the standard 64-bit floating-point format owing to the presence of exponential functions for larger numbers. To overcome this drawback, the use of the g -function $g(x) = \ln(W(\exp(x)))$ was suggested [4]. The analytical solution $V(I)$ using the g -function is as follows [4]

$$V(I) = I R_s + \frac{n_1 kT}{q} g(x_1) - \frac{n_2 kT}{q} g(x_2) - \frac{n_1 kT}{q} \ln \left[\frac{q I_{01} R_{p1}}{n_1 kT} \right] + \frac{n_2 kT}{q} \ln \left[\frac{q I_{02} R_{p2}}{n_2 kT} \right], \quad (2)$$

with

$$x_1 = \ln \left(\frac{q I_{01} R_{p1}}{n_1 kT} \right) + \frac{q (I + I_{ph} + I_{01}) R_{p1}}{n_1 kT}, \quad (3)$$

and

$$x_2 = \ln \left(\frac{q I_{02} R_{p2}}{n_2 kT} \right) - \frac{q (I - I_{02}) R_{p2}}{n_2 kT}. \quad (4)$$

We used Eqs. (2)–(4) both for simulation I-V curves and during the approximation procedure. The g -function was evaluated by using iterative procedure [4].

References

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